

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/633,792	ZOLLERS, MICHAEL W.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-1,348,618	08-1920	ZORGER WILLIAM H	362/309
B	US-1,366,946	02-1921	ROLPH THOMAS W	362/309
C	US-1,393,573	10-1921	RITTER JOHN A	362/509
D	US-1,410,077	03-1922	PECK EDWARD E	362/308
E	US-1,416,444	05-1922	BUGBEE LUCIAN W	451/42
F	US-1,751,070	03-1930	BOOTS EDMUND R; et. al.	359/528
G	US-2,556,328	06-1951	HENRY HINDS REINHARD PAUL	362/309
H	US-2,738,414	03-1956	DAVIS LOUIS E; et. al.	362/540
I	US-3,004,470	10-1961	HANS RUHLE	359/721
J	US-3,941,459	03-1976	McFarland et al.	359/859
K	US-4,209,825	06-1980	Shackelford, John T.	362/299
L	US-4,210,391	07-1980	Cohen, Allen L.	351/161
M	US-4,636,211	01-1987	Nielsen et al.	623/6.28

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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P					
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NON-PATENT DOCUMENTS

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		Examiner	Art Unit	Page 2 of 3
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-4,787,722	11-1988	Claytor, Richard N.	359/742
B	US-4,814,950	03-1989	Nakata, Yutaka	362/539
C	US-4,859,043	08-1989	Carel et al.	359/742
D	US-4,959,757	09-1990	Nakata, Yutaka	362/518
E	US-4,993,807	02-1991	Sakakibara, Koichi	359/743
F	US-4,995,715	02-1991	Cohen, Allen L.	351/161
G	US-5,349,471	09-1994	Morris et al.	359/565
H	US-5,442,488	08-1995	Pastorino, Anthony T.	359/802
I	US-5,446,565	08-1995	Komma et al.	369/44.23
J	US-5,685,631	11-1997	Dobert et al.	362/158
K	US-5,715,031	02-1998	Roffman et al.	351/161
L	US-5,808,775	09-1998	Inagaki et al.	359/212
M	US-5,897,196	04-1999	Soskind et al.	362/507

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
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Examiner		Art Unit		Page 3 of 3
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,899,559	05-1999	Lachmayer et al.	362/513
B	US-5,924,788	07-1999	Parkyn, Jr., William A.	362/329
C	US-5,986,779	11-1999	Tanaka et al.	359/19
D	US-6,007,210	12-1999	Yamamoto et al.	362/459
E	US-6,070,993	06-2000	Natsume, Kazunori	362/309
F	US-6,123,440	09-2000	Albou, Pierre	362/516
G	US-6,250,777	06-2001	Aoyama, Toshihiro	362/326
H	US-6,264,347	07-2001	Godbillon et al.	362/331
I	US-6,273,591	08-2001	Albou, Pierre	362/333
J	US-2002/0024822	02-2002	Pond et al.	362/555
K	US-2002/0034080	03-2002	Tamai, Hiroyuki	362/521
L	US-6,485,170	11-2002	Natsume, Kazunori	362/509
M	US-2002/0196639	12-2002	Weidel, Edgar	362/521

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
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